


<b>Search Notes</b>  	<b>Application/Control No.</b>  10069603	<b>Applicant(s)/Patent Under Reexamination</b>  KOBAYASHI ET AL.
	<b>Examiner</b>  Hai Vo	<b>Art Unit</b>  1794

SEARCHED			
Class	Subclass	Date	Examiner
428	319.3, 319.7, 319.9	2/2/2007	HV
521	79, 81 and 134	2/2/2007	HV
Above to date		10/9/2007	HV

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor name search	10/9/2007	HV

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner